Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10626596	SHEN ET AL.
Examiner	Art Unit
GERMAN VIANA DI PRISCO	2617

SEARCHED				
Class		Subclass	Date	Examiner
370	352		4/17/2008	GV

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST Image and keyword search in USPAT, US-PGPUB, DERWENT,	4/17/2008	GV		
EPO, JPO, and IBM_TDB (see attached search strategy)				
Inventor name and Assignee search in PALM ExPO and EAST	4/17/2008	GV		
Consulted with Rafael Perez-Gutierrez	4/17/2008	GV		
EPO Database(http://ep.espacenet.com)	4/17/2008	GV		
Updated search	12/10/2008	GV		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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